



# Studies on ATLAS pixel modules

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### Outline

### Introduction

### ATLAS pixel modules

- requirements
- concept
- assembly process
- serial powering of pixel modules

### Results on prototype modules

- optical readout
- thermal behaviour
- modules with DSM electronics (FE-I)

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### Conclusions





### Introduction

# Modules basic building unit of pixel detector:

- 3 barrels at different radii •staves with 13 modules
- 2x3 disks in forward region
  disk sectors with 6 modules
- 80 millions channels, 2000 modules







# ATLAS pixel module









## Requirements

#### **Electrical performance**

- 3000 e<sup>-</sup> threshold with a dispersion of 200 e<sup>-</sup>
- noise 200-300 e-
- efficiency > 98%

### <u>Reliability</u>

- 10 years operation in ATLAS, almost no maintenance
- thermal tolerance between -30°C and +25°C
- radiation tolerance up to 10<sup>15</sup> n<sub>eq</sub> cm<sup>-2</sup>, 500 kGy (for Blayer)
- high position stability (vertex/tracking detector)

### Production

• testability during all assembly steps

- high yield production
- material less than 3% X<sub>0</sub>





### Concept

#### **Components**

- 1 double sided silicon sensor
- 16 thinned FE chips
- 1 4-layer flex-hybrid circuit with passive components
- 1 thinned MCC
- 1 2-layer flex-hybrid (barrel/disk-pigtail) with microconnector for cable connection

#### **Interconnections**

- chip-sensor: fine pitch (50µm) PbSn or Indium bump bonding
- chip-flex: wire-bonding small wires (17.5µm)
- flex-pigtail: wire-bonding thick wire (50µm)
- Different gluing connections: sensor-flex, MCC-flex, pigtailflex, micro-connector-pigtail



Atlas pixel modules are a complex mixture between sensible components and advanced interconnections techniques







### **Assembly process**





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so far 15 hot modules have been assembled in Bonn using different sensors, FE chips, flex-hybrids, pigtails: • 4 FE-A/C, 8 FE-B, 1 FE-D2s, 2 FE-I

Many dummy modules have been assembled to learn/train the various production steps

• gluing procedures, wire-bonding, pigtail mounting, cable connection, ....

#### The module assembly procedure is now nearly clear

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• e.g. time to assemble one module from bare module, fully loaded flex without MCC and pigtail is less than a day

But module assembly still remains a complex process with ~50 single production steps !

• Quality control during production is very important





# An old story: 'Serial Powering'

#### The Problem:

- Supply voltages in DSM decrease (we are at 1.6V-2.0V). At constant power dissipation in the chip the supply currents increase.
- Because the cross section of the cables is limited, we dissipate a lot of power in the cables (in ATLAS: roughly half of the total power!) ⇒ cooling problems, material...!
- If supply current changes (digital activity), chip voltage will have dips
- Connecting modules in parallel does not help.

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- A possible solution, already proposed for other applications (e.g. CMS silicon tracker):
  - Connect modules in series
  - Supply the string of modules with a constant current *I*<sub>0</sub>
  - Every module uses a shunt regulator to generate it's digital supply
  - The analog supply voltage is generated with a linear regulator from vddd
  - Data transmission is via optical links  $\Rightarrow$  no problem with potentials
  - Power wasted is (I<sub>0</sub>-I<sub>module</sub>) x V<sub>module</sub>

If this worked, it would save a lot of

• power,... cables, connectors,... cooling, material, power supplies,... money





# Circuitry on chip/modules



• Shunt regulators have 'soft' turn-on to distribute lost power equally on chips





# Tests with FE-I single chips

- Shunt regulators and linear regulators are implemented in FE-I as testing option
- Regulators have some minor design errors but they work
- First tests with single chips show no difference to parallel powering
- Further investigation on modules are ongoing



#### **1 + 2 chips in series**



(4780 ± 105)e<sup>-</sup> thres./ (268 ± 30)e<sup>-</sup> noise





## **Optical module readout**





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## Setup for optical readout







### Setup for optical readout









### **Results:** Module with full optical readout

- at 40µA PIN current
- untuned threshold distribution of a FE-B module shows no difference to standard test setup







### **Results:** chip #4 optical readout







# Thermal behaviour of a hot module

Module 12: FE-B module with pre-production Tesla sensor and Flex2.x glued on carbon structure in flex frame

9 x cycled between 25°C and -10°C measured on the flex under full power

1 x cycled between 25°C and -25°C by switching off the power

Testbeam August 2001

20 x cycled between 25°C and -30°C without power

**Testbeam October 2001** 

Source measurement January 2002 with Am<sup>241</sup>







### Source measurement









### Source measurement





11-Sep-02



### **FE-I modules**

- Some FE-I (A/B) modules has been assembled
- bump with Pb/Sn at IZM or Indium at AMS
- using CiS/Tesla preproduction sensors
- with FH v4.1 (Compunctics) or with FH v4.2 (Dyconnex)
- 2 modules work via barrel pigtail and microcable prototypes
- first modules operated in last testbeam (2 weeks ago)









### FE-I modules: threshold and noise



Module before tuning (Mod2): threshold: (3400 ± 1200)e<sup>-</sup> Noise (290 ± 30)e<sup>-</sup>



Module after tuning (Mod1): threshold: (3000 ± 120)e<sup>-</sup> Noise (280 ± 30)e<sup>-</sup>





### FE-I module: source measurement

- three big capacitors shadowing the source
- 1 chip disabled (only 2 columns working)
- 12 non working columns





Am<sup>241</sup> source scan of Mod1

# • only 36 of 41280 pixel don't see hits !







### **Conclusions**

- a lot of experience of pixel module assembly with different chips, sensors, flex-hybrids, bumping techniques exists now
- the ATLAS pixel prototype modules shows to fulfil the challenging requirements of 10 years operation in ATLAS
  - no degradation with thermal cycling observed
  - full optical readout without performance loss possible
- modules with DSM FE-I chips successfully assembled and operated in lab and testbeam
- serial powering of modules seems to be interesting option but needs further studies



